

**Search Notes**

Application/Control No.

10/758,222

Examiner

David T. Fidei

Applicant(s)/Patent under  
Reexamination

OTAKI ET AL.

Art Unit

3728

**SEARCHED**

Class	Subclass	Date	Examiner
206	521 522 583 588 591 592 594	4/25/2006	DTF
383	3	4/25/2006	DTF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR